

# Contents

<b>Introduction</b>	<b>1</b>
<b>I Basics</b>	<b>3</b>
<b>1 Magnetism</b>	<b>5</b>
1.1 Basic Concepts . . . . .	5
1.2 Phase Transitions . . . . .	8
1.3 Surface and Finite-Size Effects . . . . .	11
1.3.1 Reduced Ordering Temperature and Dimensional Crossover . . . . .	12
1.3.2 Magnetization Profiles . . . . .	13
<b>2 Magnetism of Local Moment Systems</b>	<b>19</b>
2.1 Lanthanide Metals . . . . .	19
2.2 Europium Chalcogenides . . . . .	21
<b>3 X-Ray Diffraction</b>	<b>25</b>
3.1 Basic Quantities . . . . .	26
3.2 X-Ray Reflectivity . . . . .	28
3.3 Kinematical Diffraction from a Crystal . . . . .	32
3.4 Dynamical Theory . . . . .	35
3.5 Resonant Magnetic Soft X-Ray Scattering . . . . .	38
3.6 Typical Scans in Reciprocal Space . . . . .	40
<b>II Experimental Details</b>	<b>45</b>
<b>4 Soft X-Ray Scattering Apparatus</b>	<b>47</b>
4.1 Diffractometer . . . . .	47
4.2 Detectors . . . . .	48
4.3 Vacuum Chamber and Vacuum Conditions . . . . .	50
4.4 Alignment Procedure . . . . .	52
4.5 Characterization of the Instrument . . . . .	54
<b>5 Samples</b>	<b>57</b>
5.1 Thin Lanthanide Metal Films . . . . .	57
5.1.1 Sample Preparation . . . . .	57

5.2	Europium Telluride Thin Films . . . . .	61
5.2.1	Sample Properties . . . . .	61
5.2.2	Sample Holder . . . . .	64
<b>III</b>	<b>Results</b>	<b>67</b>
<b>6</b>	<b>Lateral Confinement and Reduced <math>T_N</math> in Holmium</b>	<b>69</b>
6.1	Single-Crystalline Holmium Films . . . . .	69
6.2	Polycrystalline Holmium Films . . . . .	75
<b>7</b>	<b>Resonant Magnetic Scattering from EuTe</b>	<b>79</b>
7.1	Overview and Characterization . . . . .	79
7.1.1	Structural Properties . . . . .	82
7.1.2	The Eu-M <sub>5</sub> Absorption Threshold . . . . .	85
7.1.3	Polarization Dependence: The Magnetic Structure . . . . .	88
7.1.4	In-Plane Coherence and Magnetic Thickness . . . . .	91
7.2	The Ordered Phase: Layer-Resolved Magnetization . . . . .	95
7.2.1	Qualitative Discussion . . . . .	98
7.2.2	Reconstruction of Magnetization Profiles . . . . .	98
7.2.3	Atomic-Layer-Resolved Magnetization Profiles . . . . .	104
7.3	Magnetic Short-Range Correlations and Dimensional Crossover . . . . .	108
7.3.1	Magnetic Critical Scattering from EuTe . . . . .	109
7.3.2	Temperature-dependent Correlation Length . . . . .	111
7.3.3	Dimensional Crossover . . . . .	112
<b>Summary and Perspectives</b>		<b>117</b>
<b>A</b>	<b>The Measured Intensity</b>	<b>119</b>
<b>B</b>	<b>Simulated Annealing</b>	<b>125</b>
<b>C</b>	<b>Refractive versus Scattering Picture</b>	<b>129</b>
<b>Bibliography</b>		<b>140</b>